10/552948

IN THE UNITED STATES PATENDAND TRADEMARK OFFICE

Applicant/Inventor: C

Chen et al.

Title:

Read And Erase Verify Methods And Circuits Suitable For Low

Voltage Non-Volatile Memories

Application No.:

Unassigned

Filing Date:

Herewith

Examiner:

Unassigned

Group Art Unit:

Unassigned

Docket No.:

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San Francisco, California October 13, 2005

Mail Stop PCT Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

PRELIMINARY AMENDMENT FOR FILING UNDER 35 U.S.C. §371

Sir:

Please preliminarily amend the above-identified patent application as set forth herein.

Attorney Docket No.: SNDK.284US1

Express Mail No.: EV 663648212 US

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